## Search Notes



Applicat	ion/Control No.	Applicant(s)/Patent Under Reexamination
1059063	0	JENSEN ET AL.
Examine	r	Art Unit
Young J	Kim	1637

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES					
Search Notes	Date	Examiner			
reviewed search strategy for 10/590,632	11/14/2008	/YJK/			
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) - see enclosed for text-search strategy	8/6/2009	/YJK/			
NPL - search terms: spore, lysis, alternating electric field, bacterial/bacteria spore.	8/6/2009	/YJK/			
updated	3/14/2011	/YJK/			

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference history - see enclosed	10/7/2010	/YJK/

/Young J Kim/ Primary Examiner.Art Unit 1637		/Young J Kim/ Primary Examiner.Art Unit 1637
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